

**Search Notes**

Application/Control No.

10/045,606

Examiner

Steven Blount

Applicant(s)/Patent under  
Reexamination

SHIN ET AL.

Art Unit

2661

**SEARCHED**

Class	Subclass	Date	Examiner
370	389	9/1/05	SB
↓	230	↓	↓
↓	230.1	↓	↓
↓	465	↓	↓
↓	463	↓	↓
370	471	9/1/05	SB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR